Quantum dot dephasing by fractional quantum Hall edge states

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We consider the dephasing rate of an electron level in a quantum dot placed next to a fluctuating edge current in the fractional quantum Hall effect. Using perturbation theory, we show that this rate has an anomalous dependence on the bias voltage applied to the neighboring quantum point contact, which originates from the Luttinger liquid physics which describes the Hall fluid. General expressions are obtained using a screened Coulomb interaction. The dephasing rate is strictly proportional to the zero-frequency backscattering current, which allows us to describe exactly the weak to strong backscattering crossover using the Bethe-ansatz solution.

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Transport through a quantum dot is typically affected by the environment which surrounds it: the level of such a dot acquires a finite linewidth if this environment has strong charge fluctuations which couple to the dot. Several seminal experiments, performed with a quantum dot embedded in an Aharonov-Bohm loop, probed the phase coherence of transport when this dot is coupled to a controlled environment, such as a quantum point contact (QPC) with a fluctuating current. Charge fluctuations in the QPC create a fluctuating potential at the dot, modulate the electron levels in the dot, and destroy the coherence of the transmission through the dot. The destruction of coherence is called “dephasing.” A general theoretical framework for describing dephasing has been presented in Refs. 7 and 8 and was applied to a quantum Hall geometry and to a normal-metal–superconductor QPC. In all of the above, the dephasing rate typically increases when the voltage bias of the QPC is increased.

The purpose of the present paper is to discuss the case of dephasing from a QPC in the fractional quantum Hall effect (FQHE) regime. QPC transmission can then be described by tunneling between edge states, the quantized analog of the dot. The destruction of coherence is called “dephasing.” A general theoretical framework for describing dephasing has been presented in Refs. 7 and 8 and was applied to a quantum Hall geometry and to a normal-metal–superconductor QPC. In all of the above, the dephasing rate typically increases when the voltage bias of the QPC is increased.

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FIG. 1. Schematic description of the setup: the quantum dot (top) is coupled capacitively to a quantum point contact in the FQHE regime: (a) case of weak backscattering and (b) case of strong BS.

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The quasiparticle operator in the case of strong BS is \( \psi(x) = e_{\frac{1}{2} \phi(x) / 2 \pi \alpha} \) (the spatial cutoff is \( \alpha = v_F \tau_0 \), with \( \tau_0 \) the temporal cutoff), and in the strong BS case the electron operator is obtained with the substitution \( \nu \rightarrow 1/\nu \).

The Hamiltonian describing the interaction between the dot and QPC reads \( H_{\text{int}} = c^\dagger c f(x) \rho_1(x) \), with \( f(x) \) a Coulomb interaction kernel, which is assumed to include screening by the nearby gates \( f(x) = e_{\frac{2}{2} e^{2} / \sqrt{\lambda_{x}^{2} + d^{2}}} \), where \( d \) is the distance from the dot to the edge and \( \lambda_{x} \) is a screening length.

The dephasing of an electron state in a dot coupled to a fluctuating current is caused by the electron density fluctuations, which generate a fluctuating potential in the dot, resulting in a blurring of the energy level \( \epsilon_0 \). The dephasing rate, expressed in terms of irreducible charge fluctuations in the adjacent wire, is written as \( \Gamma_{\text{deph}} \):

\[
\tau_{\psi}^{-1} = \frac{1}{4 \hbar^2} \int_{-\infty}^{\infty} dt \int dx f(x) \int dx' f(x') \times \langle \langle \rho_1(x, t) \rho_1(x', 0) + \rho_1(x', 0) \rho_1(x, t) \rangle \rangle.
\]

In normal and superconducting systems, the dephasing rate can be calculated using the scattering approach. For Luttinger liquids and in particular for the FQHE, it is convenient to use the Keldysh approach. Here a tunneling event at \( x = 0 \) creates an excitation which needs to propagate to the location of the dot. The equilibrium (zero-point) contribution to the dephasing rate corresponds to the zero order in the tunneling amplitude \( \Gamma_0 \) [it is labeled \( (\tau_{\psi}^{-1})^{(0)} \)]. There is no contribution to first order in the tunneling Hamiltonian, while the nonequilibrium contribution corresponding to the second order in \( \Gamma_0 \) exists, \( (\tau_{\psi}^{-1})^{(1)} = \sum_{\eta} \frac{2}{\nu} \int_{-\infty}^{\infty} dt \int dx f(x) \int dx' f(x') \times \sum_{\eta_1, \eta_2} \delta_{\eta_1, \eta_2} G_{\eta_1}^{-\eta_2}(x-x', t). \) (4)

The bosonic Green’s function is \( G_{\eta_1}^{-\eta_2}(x-x', t_1-t_2) = \langle \phi_j(x, t_1^0) \phi_j(x', t_2^0) - \phi_j^\dagger(0) \phi_j(0, t_1^0) \rangle \). The coefficients \( \eta, \eta_1, \eta_2 = \pm \) identify the upper and lower branches of the Keldysh contour. For second order, since \( \psi_1, \psi_2 \) are independent in the absence of tunneling, we obtain

\[
\sum_{\eta, \eta_1, \eta_2} \left\langle \left\langle \rho_1(x, t) \rho_1(x', 0) + \rho_1(x', 0) \rho_1(x, t) \right\rangle \right\rangle \times \delta_{\eta_1, \eta_2} G_{\eta_1}^{-\eta_2}(x-x', t).
\]

Quasiparticle conservation imposes \( \epsilon_1 = -\epsilon_2 = \epsilon \), so

\[
(\tau_{\psi}^{-1})^{(2)} = -\frac{\nu}{4 \pi^2 \hbar^2} \int_{-\infty}^{\infty} dt \int dx f(x) \int dx' f(x') \sum_{\eta, \eta_1, \eta_2} \eta_1 \eta_2 \int_{-\infty}^{\infty} dt_2 e^{i(x, t_1^0 + \epsilon_1 \epsilon_2 \epsilon_1 \epsilon_2) / 2 \hbar} \times \delta_{\eta_1, \eta_2} G_{\eta_1}^{-\eta_2}(x-x', t). \]

The dephasing rate depends on the geometry of the setup via the length scales \( d, \lambda_x, \) and \( \alpha \). The equivalent result for strong BS is obtained by replacing \( \nu \rightarrow 1/\nu \) next to the Green’s function (duality).

The assumption of strong screening \( \lambda_x \sim \alpha = v_F \tau_0 \) is made \([f(x) = 2e^2 \alpha \delta(x)/d] \); it turns out that this assumption is not necessary, and it will be relaxed later on. Inserting the Green’s function at finite temperature \( G_{\eta_1}^{-\eta_2}(x, t) = -\ln[\sinh(\pi(x/v_F t))/2 + i\tau_0(h/\hbar)] \) in the dephasing rate [Eqs. (4)–(6)] gives \( (\tau_{\psi}^{-1})^{(0)} \)

\[= 4e^4 \alpha^2 \nu/(\pi \hbar \beta d^2) \]

and with the change of variables \( \tau_1 = t_1 - t_2, \tau_1 = t_1 - t_2, \tau_2 = t_2 \), we obtain:

\[
(\tau_{\psi}^{-1})^{(2)} = -\frac{1}{2 \hbar^2} \int_{-\infty}^{\infty} dt \cos[\omega_0 t] \sum_{\eta, \eta_1, \eta_2} \sinh^{2 \eta} \left( \frac{\pi}{h \beta} i \tau_0 \right) \sum_{\eta, \eta_1, \eta_2} \sinh^{2 \eta} \left( \frac{\pi}{h \beta} (-\eta + i \tau_0) \right) \times \int_{-\infty}^{\infty} dt_e \left[ \text{sgn}(\tau_1) \text{coth} \left( \frac{\pi}{h \beta} (-\eta \text{sgn}(\tau_1) + i \tau_0) \right) + \text{coth} \left( \frac{\pi}{h \beta} (\eta \tau_1 + i \tau_0) \right) \right] \times \int_{-\infty}^{\infty} dt_e \left[ - \text{sgn}(\tau_2) \text{coth} \left( \frac{\pi}{h \beta} (-\eta \text{sgn}(\tau_2) + i \tau_0) \right) + \text{coth} \left( \frac{\pi}{h \beta} (\eta \tau_2 + i \tau_0) \right) \right].
\]
In the integral over $\tau$, we change variables to $t=-\tau+it_0\pm\hbar\beta/2$ for the first (second) term, and the integral now runs in the complex plane from $-\infty + it_0\pm\hbar\beta/2$ to $+\infty + it_0\pm\hbar\beta/2$. We bring it back to $(-\infty, +\infty)$ by deforming the contour because there are no poles in the integrand. For $t_0 \ll \omega_0^{-1}, \hbar\beta$, one obtains

$$
\tau_{\phi}(\nu) = \frac{\nu^2 \tau_0^2}{\pi^2 \hbar^2 v^2 d^2} \Gamma(2\nu) \frac{2\nu - 1}{\hbar\beta} \cos \left( \frac{\omega_0 \hbar \beta}{2} \right) \times \left| \Gamma \left( \nu + \frac{\omega_0 \hbar \beta}{2\pi} \right) \right|^2.
$$

In the zero-temperature limit, we have $(\tau_{\phi}(\nu))_{\nu=0} = 0$ and

$$
(\tau_{\phi}(\nu))_{\nu=1}^2 = \frac{e^{4\Gamma_0^2}}{\pi^2 \hbar^2 v^2 d^2} \Gamma(2\nu) \left| \omega_0 \right|^{2\nu-1}.
$$

Note that $(\tau_{\phi}(\nu))_{\nu=0}^2 = (e/\nu d)S_0(0)$, with $S_0(0) = \int dt \langle (I(t)I(0)) \rangle$ the zero-frequency BS current noise.

The nonequilibrium contribution of the dephasing rate is proportional to the zero-frequency noise in the quantum Hall liquid, which is computed in Refs. 14–17. This is understood from the continuity equation, which relates the current operator to the density operator.\(^{10}\) The theoretical predictions of noise in the weak and strong BS limits have been verified in point-contact experiments at filling factor $\nu = 1/3, 1/5$.\(^{19,20}\)

At zero temperature, the nonequilibrium dephasing rate of Eq. (9) for weak BS depends on the QPC bias with the exponent $2\nu - 1 < 0$. This is in sharp contrast with Ref. 7, where the QPC bias dependence is linear. We also calculate numerically this contribution at finite temperatures and consider it as a function of the filling factor or the QPC voltage bias. In our numerical calculations, we choose the inverse cutoff $\tau_0^{-1}$ as the energy scale and the nonequilibrium contribution for the dephasing rate is plotted in units of $e^{4\Gamma_0^2} \tau_0^2 / (\pi^2 \hbar^2 v^2 d^2)$.

In Fig. 2, we plot the dependence of this contribution on the filling factor $\nu$ for both weak and strong BS cases for several temperatures ($\beta = 5, 10, 50$) at fixed QPC bias. $\nu$ is considered here as a continuous variable, while it has physical meaning only at Laughlin fractions.\(^{11}\) For the strong BS case, the dephasing rate increases when the filling factor increases. At small $\nu$, it is zero; then, it increases rapidly. The higher the temperature, the faster the increase. For the weak BS case, the shape of the dephasing rate depends on the ratio of QPC bias and temperature. At low temperature ($1/\beta \ll eV$), the dephasing rate function has a local maximum at $\nu = 1/2$, the position of which depends on temperature: when the temperature increases, it gets closer to $\nu = 1/2$ and its height decreases, the rate at $\nu = 1/3$ is smaller than that at $\nu = 1/3$. This result demonstrates that for two different filling factors, we can have comparable dephasing rates. Around the crossover in temperature ($1/\beta eV = 1$), the local maximum in the dephasing rate broadens. At high temperature ($1/\beta > eV$), the dephasing rate increases when the filling factor increases. We find that the dephasing rates evaluated at different temperatures coincide at the (unphysical) value $\nu = 1/2$, because the hyperbolic cosine multiplied by the squared modulus of the gamma function with $\nu = 1/2$ in Eq. (8) does not depend on temperature, while at the same time the exponent $(2\nu - 1)$ is zero: this is known for perturbative calculations of the backscattering current and noise.

In Fig. 3, the dependence of the nonequilibrium contribution of the dephasing rate on the QPC bias voltage is plotted for several temperatures. In the case of strong BS, the dephasing rate increases when the bias $eV$ increases. When the temperature is low enough ($1/\beta \ll eV$), the dephasing rate saturates. In the case of high temperatures ($1/\beta > eV$), the dephasing rate also increases when $eV$ increases, but it increases from a finite value (not shown), which is proportional to the temperature. Things are quite different at weak BS. At high temperatures, the dephasing rate decreases when we increase $eV$: this behavior is symptomatic of current and noise characteristic in a Luttinger liquid. In the low-temperature case $1/\beta \ll eV$, for small $eV$, the lower the tem-
perature, the larger the dephasing rate and the faster it decreases when we increase $eV$. At $T=0$, the dephasing rate is “infinite” at $eV=0$. This Luttinger liquid behavior is in sharp contrast with the result of Ref. 7.

The charge fluctuations are directly related to the current fluctuations along the edges. The fluctuations of the currents along the edges are also identical to the fluctuations of the tunneling current. The tunneling current fluctuations were computed nonpertubatively using Bethe-ansatz techniques. We can therefore invoke current conservation at the point contact to derive a general formula for the decoherence rate, which describes the crossover from weak to strong BS (Ref. 22):

$$\left(\tau_{\phi}^{-1}\right)^{(2)} = \frac{e^2}{\hbar^2} \frac{\nu}{1 - \nu} \left(V G_{\text{diff}} - I\right),$$

where $G_{\text{diff}}$ is the differential conductance and $I$ is the current, defined in Refs. 22 and 24. Equation (10) allows us to describe the crossover in the dephasing rate from the weak to the strong BS regime.

Remarkably, for the weak and strong BS regimes, it is possible to go beyond the strong screening limit, and one can compute Eq. (6) for an arbitrary Coulomb kernel $f(x)$: the triple-time integral in the second-order contribution to the dephasing rate is computed analytically. Further simplifications occur if $f(x)$ is even. The result can be displayed in terms of the ratio between the arbitrary screening dephasing rate and the strong screening dephasing rate (both nonequilibrium contributions):

$$F = \frac{\left(\tau_{\phi}^{-1}\right)^{(2)}_{\text{weak}}}{\left(\tau_{\phi}^{-1}\right)^{(2)}_{\text{strong}}} = \frac{d^2}{(e\alpha)^2} \left[ \int_{0}^{\infty} dx \, f(x) \right]^2,$$

where the integral is a function of $d/\lambda_s$ and we recall that $\alpha$ is the spatial cutoff. If the Coulomb interaction kernel $f(x)$ is chosen as suggested before, the dephasing rate at arbitrary $\lambda_s$ has an analytical expression: $F = (\pi d/2 \alpha)^2 [E_0(d/\lambda_s) + N_0(d/\lambda_s)]$, where $E_0(d/\lambda_s)$ and $N_0(d/\lambda_s)$ are the Weber and Neumann functions, both of zero order. $F$ is plotted in the inset of Fig. 3, and $(\alpha/d)^2$ is taken to be a small constant. $F$ is infinite in the absence of screening, but in practical situations, the presence of metallic gates always imposes a finite screening length. $F$ decreases with $d/\lambda_s$ and approaches 1 when $\lambda_s$ is close to the spatial cutoff $\alpha$ (strong screening). The dephasing rate increases when the screening decreases.

To summarize, we have established a general formula for the dephasing rate of a quantum dot located in the proximity of a fluctuating fractional edge current. In the case where screening is strong, we have shown that the dephasing rate is given by the tunneling current noise, regardless of the regime (weak or strong BS) which is considered. For weaker screening, the spatial dependence of the density-density correlation function has to be taken into account, but we have shown explicitly that the long-range nature of the Coulomb interaction can be included as a trivial multiplicative factor. We conjecture that in order to describe the crossover in the dephasing rate between weak and strong backscattering cases for arbitrary screening, it is sufficient to use the strong screening crossover result of Eq. (10) and to insert it into Eq. (11). On the one hand, the fact that the dephasing rate decreases with increasing voltage can be reconciled with the fact that the charge noise is directly related to the BS current noise in the FQHE. There it is known, and seen experimentally, that when the bias voltage dominates over the temperature, both the tunneling current and noise bear a power-law dependence $\sim V^{2m-1}$ with a negative exponent. On the other hand, the fact that at low temperatures the dephasing rate for fractional filling factors can be lower than that of the integer quantum Hall effect comes as a surprise, which is contained in the temperature-voltage crossover formula of Eq. (8). It is yet another consequence of chiral Luttinger liquid theory.

The present results could be tested with gated heterostructures as in Ref. 6 [see Fig. 4(a) of this work], provided that the electron mobility and the magnetic field are further increased in order to achieve the FQHE regime and provided that the quantum dot is placed next to the QPC as in Fig. 1.